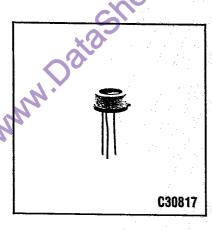
# Electro

# **Photodiode** C30817



# Silicon Avalanche Photodiode for **General-Purpose Applications**

- High Quantum Efficiency 85% typical at 900 nm — 18% typical at 1060 nm
- Spectral Response Range (10% pts) 400 to 1100 nm
- Fast Time Response Rise time typically 2 ns Fall time typically 2 ns
- Wide Operating Temperature Range -40°C to +70°C
- Hermetically-Sealed Low-Profile TO-5 Package

RCA Type C30817 is a general-purpose silicon avalanche photodiode made using a double-diffused "reach through" structure. This structure provides high responsivity between 400 to 1100 nanometers as well as fast rise and fall times at all wavelengths. Because the fall time characteristic has no "tail", the responsivity of the device is independent of modulation frequency up to about 200 MHz.

The C30817 is hermetically sealed behind a flat glass window in a modified low-profile TO-5 package.

This device is useful in a wide variety of applications including laser detection, ranging, optical communications, high-speed switching, and transit-time measurements.

# Maximum Ratings, Absolute Maximum Values

Reverse Bias Dark Current	max. μA
Photocurrent Density, J <sub>p</sub> , at 22° C: Average value, continuous operation	mA/mm² mA/mm²
Forward Current, I <sub>F</sub> , at 22°C: Average value, continuous operation	
Maximum Total Power Dissipation at 22°C:	max. W
Ambient Temperature  Storage, $T_{stg}$ 60 to + 100  Operating, $T_A$ 40 to + 70  Soldering:  For 5 seconds200	°C °C

#### **Mechanical Characteristics**

hotosensitive Surface:	
Shape	Circular
Useful area	
Useful diameter	0.8 mm

### **Optical Characteristics**

#### Field of Viewa:

See Figure 9

Full angle ( a ) for totally illuminated photosensitive surface	110	deg
Full angle ( $\alpha'$ ) for partially illuminated photosensitive surface		• -

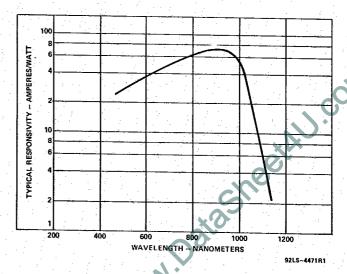
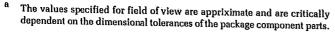


Figure 1 — Typical Spectral Responsivity Characteristic at a Gain of 120

C30817

Floatilant	1 :		<del></del>	·
Electrical Characteristics at T <sub>A</sub> =22°C	At the DC reverse operating voltage V <sub>R</sub> supplied with the device and a light spot diameter of 0.25 mm (0.01"), unless otherwise specified. See footnote <sup>b</sup> .		Units	
Breakage Voltage, V <sub>BR</sub>	Min.	Тур.	Max.	
	300	375	475	V

	wise s	y, unless specified. Dotnote b.	other-	
Breakage Voltage,	Min.	Тур.	Max.	
V <sub>BR</sub>	300	375	475	v
For V <sub>BR</sub> at other Temperatures, see Figures 2 and 3.				
Temperature Coefficient of V <sub>R</sub> for Constant Gain		2.2		11/00
Gain			_	V/°C
Responsivity:		120		
At 900 nm	65	75		A/W
At 1060 nm	15	18		A/W
Quantum Efficie,				
At 900 nm At 1060 nm	_	85 18	_	%
Total Dark		10		%
Current, I <sub>d</sub>	_	5 × 10 - 8	2 × 10 - 7	A
Noise Current, $i_n$ f = 10  kHz,	L			
⇔f = 1.0 Hz See Figure 5		1 x 10 - 12	2 x 10 - 12	A/Hz <sup>1/2</sup>
Capacitance, C <sub>d</sub>	· —	2	4	pF
Series Resistance		_	15	Ω



2

ns

ns

3

3

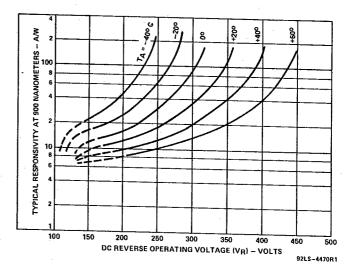


Figure 2 — Typical Responsivity at 900 nm vs Operating Voltage

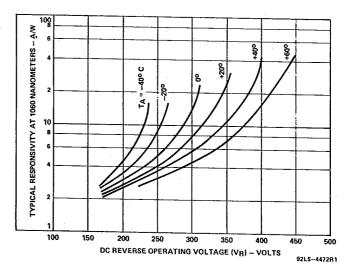


Figure 3 — Typical Responsivity at 1060 nm vs Operating Voltage

Rise Time, t<sub>r</sub>:

 $R_L = 50 \Omega$ ,

Fall Time:  $R_L = 50 \Omega$ ,  $\lambda = 900 \text{ nm},$ 90% to 10% pts.

 $\lambda = 900 \text{ nm},$ 

10% to 90% pts.

A specific value of  $V_{R}$  is supplied with each device. When the photodiode is operated at this voltage, the device will meet the electrical characteristic limits shown above. The voltage value will be within the range of 275 to 425 volts.

C30817

T=41-51

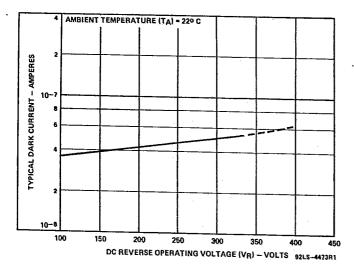


Figure 4 — Typical Dark Current vs Operating Voltage

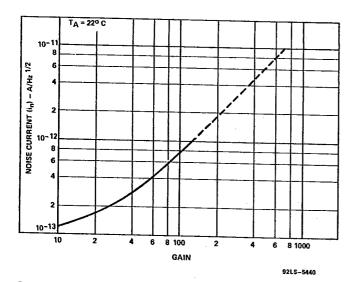


Figure 5 — Typical Noise Current vs Gain

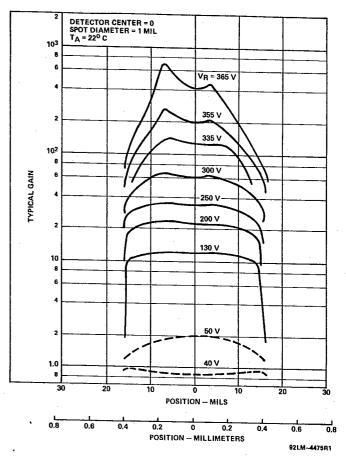


Figure 6 — Typical Gain vs Light Spot Position

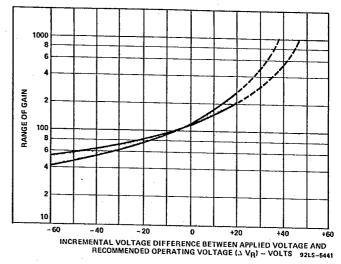
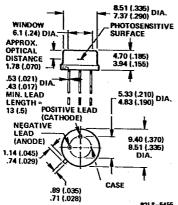
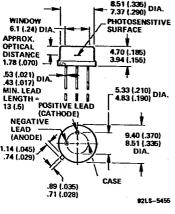


Figure 7 — Variation of Gain as a Function of Difference Between Actual Applied Operating Voltage and Recommended Operating Voltage

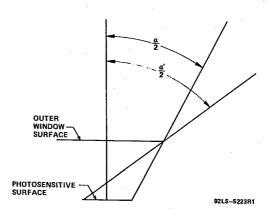




#### Low-Profile Package TO-5

Note: Optical distance is defined as the distance from the surface of the silicon chip to the front surface of the window.

Figure 8 — Dimensional Outline



For incident radiation at angles  $\leq \frac{a}{2}$ , the photosensitive surface is tatally sitive surface is totally illuminated.

For incident radiation at angles  $> \frac{\alpha}{2}$  but  $\le \frac{\alpha'}{2}$ , the photosensitive surface is partially illuminated.

Figure 9 — Definition of Half-Angle Approx. Field-of-View. (Scale is exaggerated for clarity)

# Warning — Personal Safety Hazards

Electric Shock — Operating voltages applied to this device present a shock hazard.

Dimensions in millimeters. Dimensions in parentheses are in inches.

For further information, please contact your local RCA Electro Optics representative or RCA Inc., Electro Optics, P.O. Box 900, Vaudreuil, Canada J7V 7X3 Tel.: (514) 455-6191

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